Search Notes

Application/Cont	rol No
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Thomas D. Lee

Applicant(s)/Patent under
Reexamination
OGAWA, HIDEHIKO
Art Unit

	SEARCHED				
Class	Subclass	Date	Examiner		
358	1.15, 402, 440	6/7/2005	TDL		
379	100.01	6/7/2005	TDL		
379	100.08	6/7/2005	TDL		
379	100.13	6/7/2005	TDL		
379	100.17	6/7/2005	TDL		
updated		9/15/2005	TDL		
updated		12/2/2005	TDL		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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	ce Search tout	12/2/2005	TDL	

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	DATE	EXMR
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